

Second GreEnergy workshop - Wideband optical antennae for use in energy harvesting applications

Monte Carlo simulations of graphene ballistic diodes

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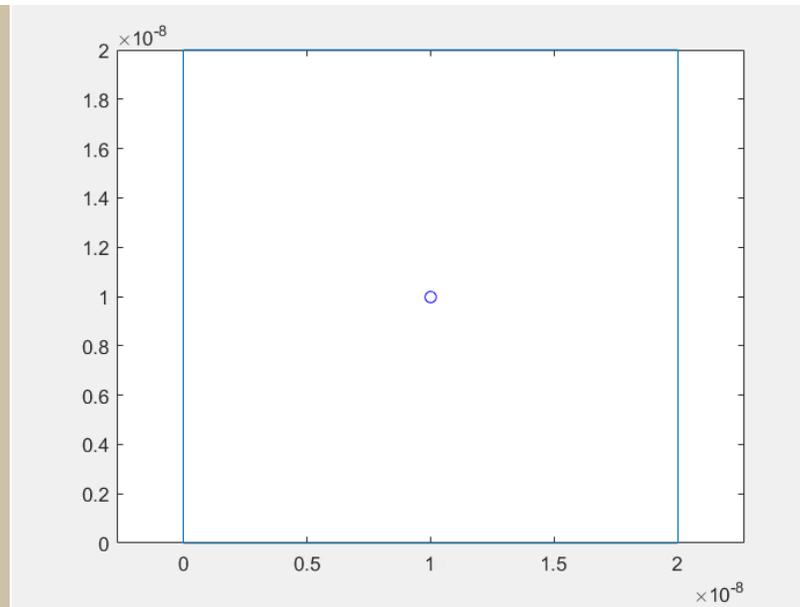
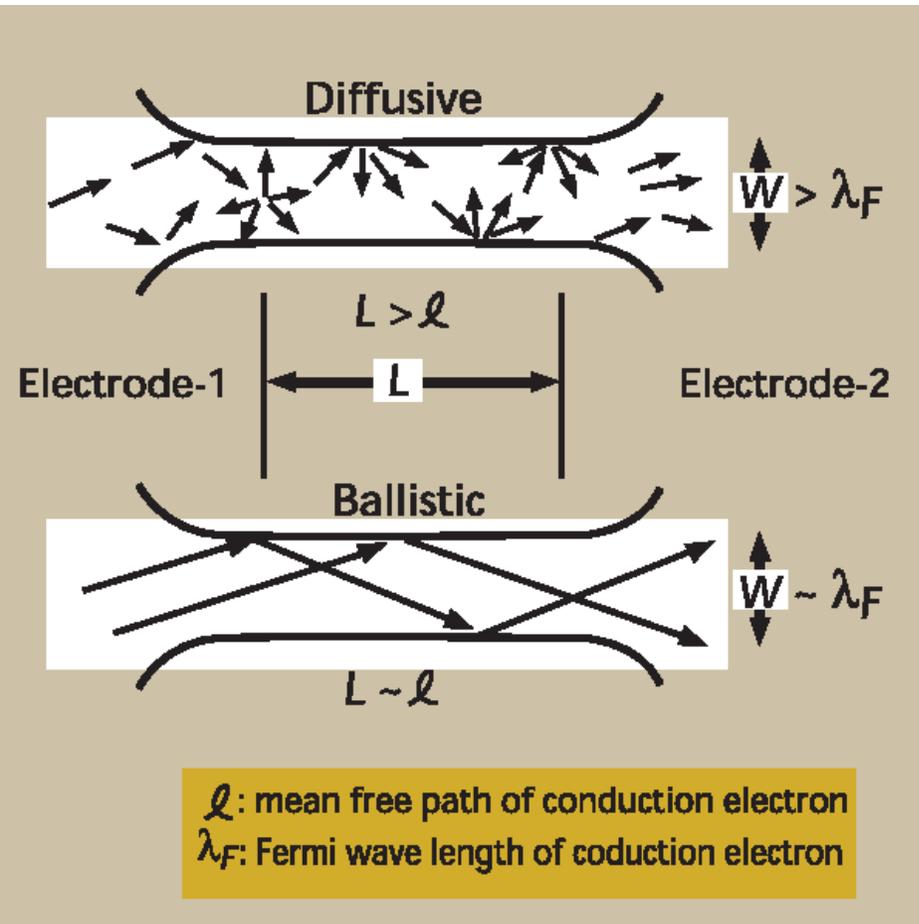
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9 September 2024

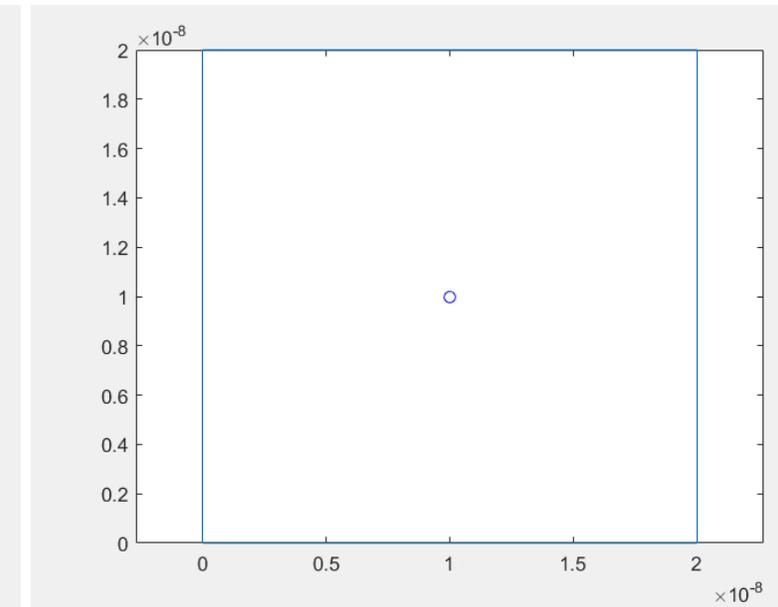
Outline

- **Introduction**
- Model description
- Results
- Conclusion

Introduction: Ballistic transport



Ballistic transport

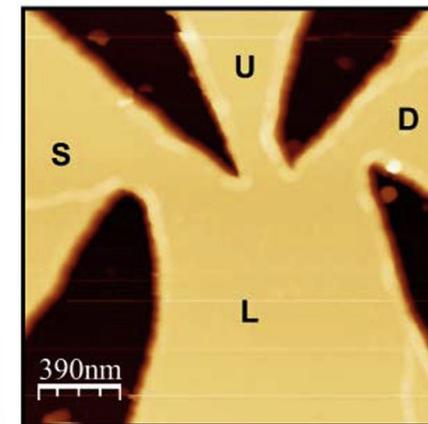
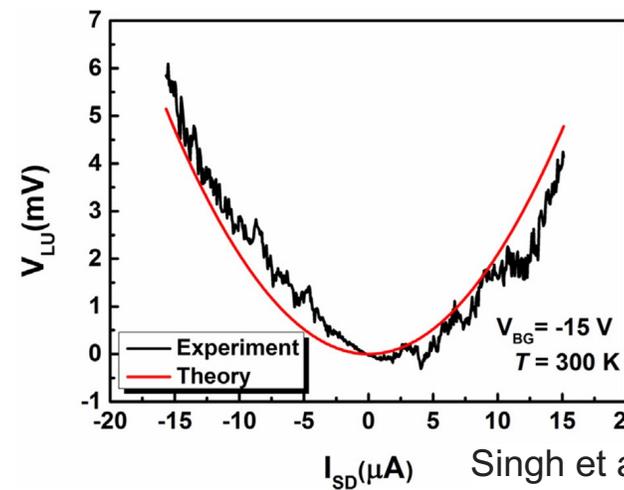
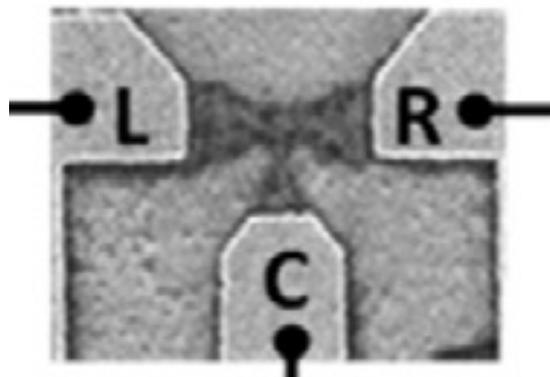
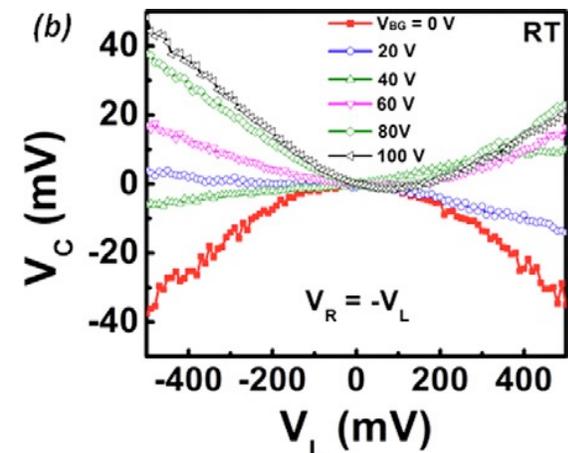


Diffusive transport

- In ballistic regime carrier's trajectory can be modified by device geometry

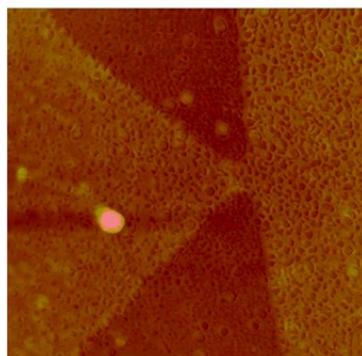
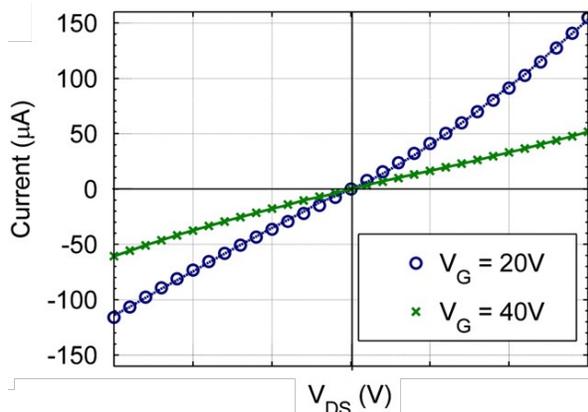
Takayanagi, Kunio, Y. Kondo, and H. Ohnishi. "Suspended gold nanowires: ballistic transport of electrons." JSAP int 3.8 (2001)..

Introduction: Ballistic diodes



Singh et al. "Graphene based ballistic rectifiers." *Carbon* 84 (2015): 124-129.

Kim et al. "Nonlinear behavior of three-terminal graphene junctions at room temperature." *Nanotechnology* 23.11 (2012): 115201.



Moddel et al. "Ultrahigh speed graphene diode with reversible polarity." *Solid State Communications* 152.19 (2012): 1842-1845.

- Graphene structures with geometrical asymmetry
- Rectification a non-linear effect arising from geometrical features and it is favoured by ballistic transport conditions
- Experimental results demonstrates the non-linear behavior

Introduction: Graphene ballistic diodes

- **No built-in potential/space charge region**
 - No threshold voltage → small signal rectification
 - No parasitic capacitance → high frequencies rectification
- **Experimental evidence**
 - Capacitance estimation \approx aF & rectification up to 28 THz for 2 terminal device [1]
 - THz imaging for 4 terminal device [2]

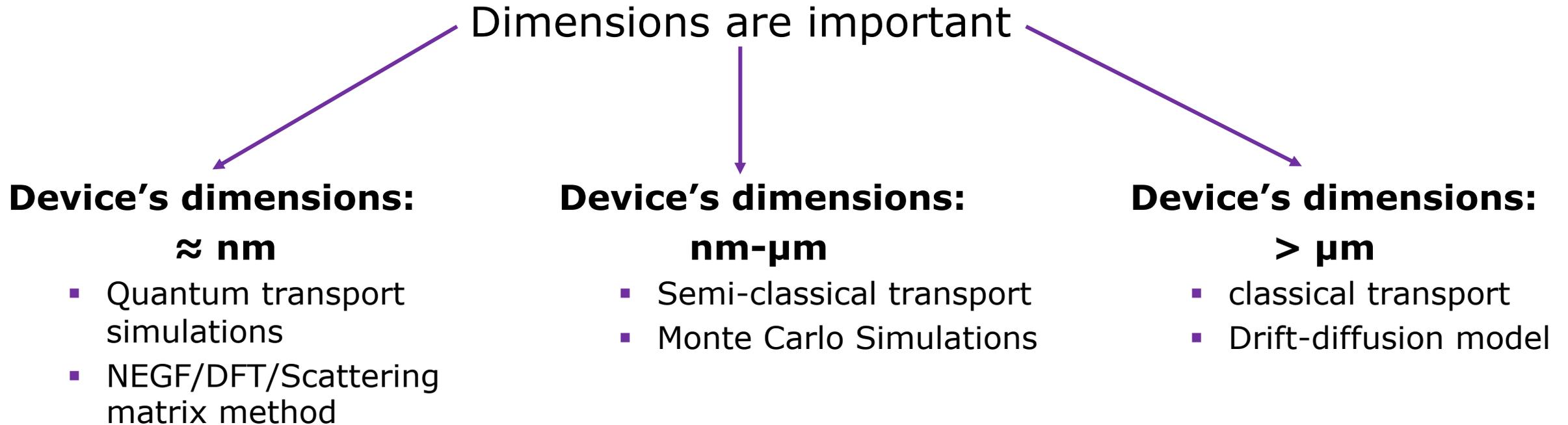
➤ Energy harvesting applications

- **Why graphene?**
 - Need ballistic transport
 - Graphene has high mobility at room temperature

[1] Zhu et al. "Graphene geometric diodes for terahertz rectennas." *Journal of Physics D: Applied Physics* 46.18 (2013): 185101.

[2] Auton et al. "Terahertz detection and imaging using graphene ballistic rectifiers." *Nano letters* 17.11 (2017): 7015-7020.

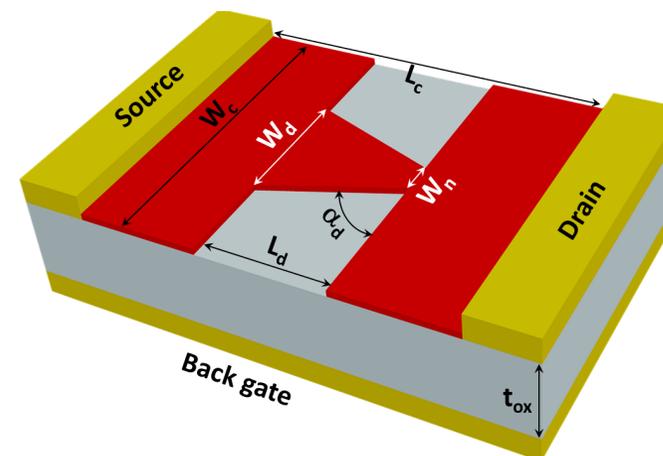
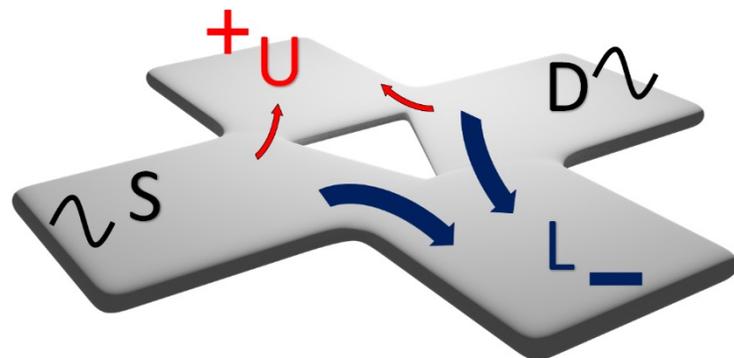
Introduction: Simulation strategy



Outline

- Introduction
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Model: Simulated structures



1. Mixed model Landauer-Buttiker and Monte Carlo

- Uniform electric field regime (No electrostatics effects)
- Mixed carrier transport
- Ballistic and scattering regime

4. Self-consistent simulation

2. Uniform electric field regime (No self-consistency with Poisson equation)

- Ballistic regime & only electron transport

3. Self-consistent simulation (all the electrostatics effects are taken into account)

- 1) Ballistic regime & only electron transport
- 2) Time domain simulation
- 3) Mixed carried transport
- 4) Scattering effects due to intrinsic and remote phonons, grain boundary and defects

Model: MC Landauer-Buttiker model

Synergistic use of Monte Carlo Simulation and Landauer-Buttiker formalism

Imposing $I_L = I_U = 0$ we find

$$V_{LU} = \frac{G_{LS}(V_{SD})G_{UD}(V_{SD}) - G_{LD}(V_{SD})G_{US}(V_{SD})}{G_{LS} - (G_{SL}(V_{SD}) + G_{DL}(V_{SD}))(G_{LD}(V_{SD}) + G_{LS}(V_{SD}))} V_{SD} = \frac{A(V_{SD})}{B(V_{SD})} V_{SD}$$

$$G_{ij}(n, V_{SD}) = G_{ij}^e(n, V_{SD}) + G_{ij}^h(p, V_{SD})$$

$$G_{ij}^{e/h}(V_{SD}) = \frac{2q^2 W k_b T}{\pi^2 v_f \hbar^2} T_{ij}(V_{SD}) \log(1 + e^{E_f/k_b T})$$

T_{ij} is the transmission probability $0 \leq T_{ij} \leq 1$ where j is the injection and i the collection terminal

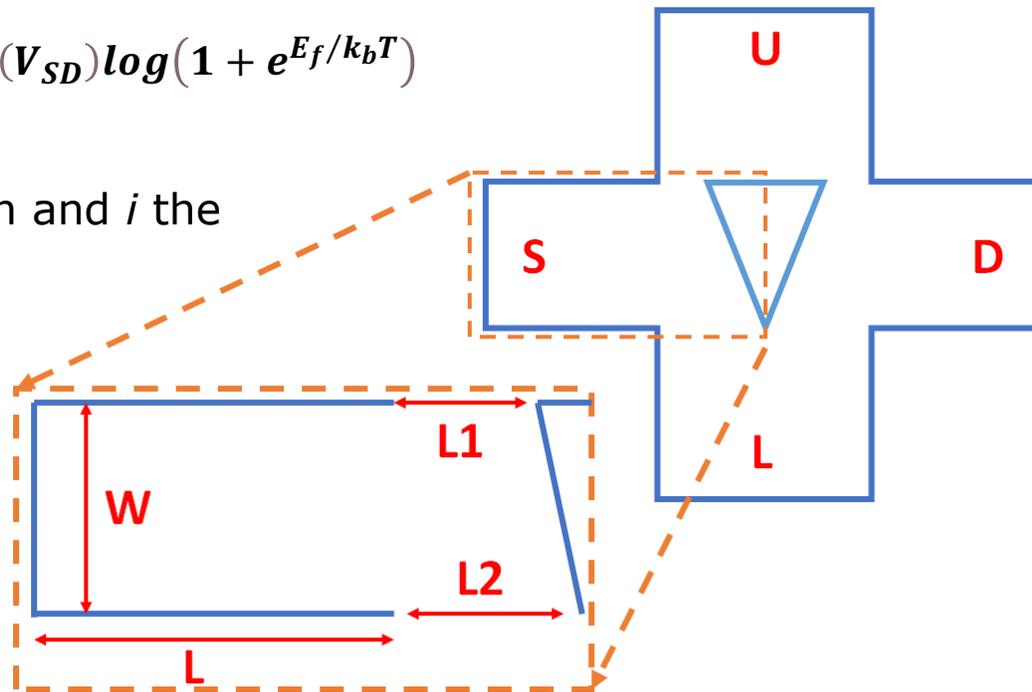
T_{ij} calculated with MC simulator

Thanks to symmetry conditions we can restrict simulations to a sub-region of the overall device

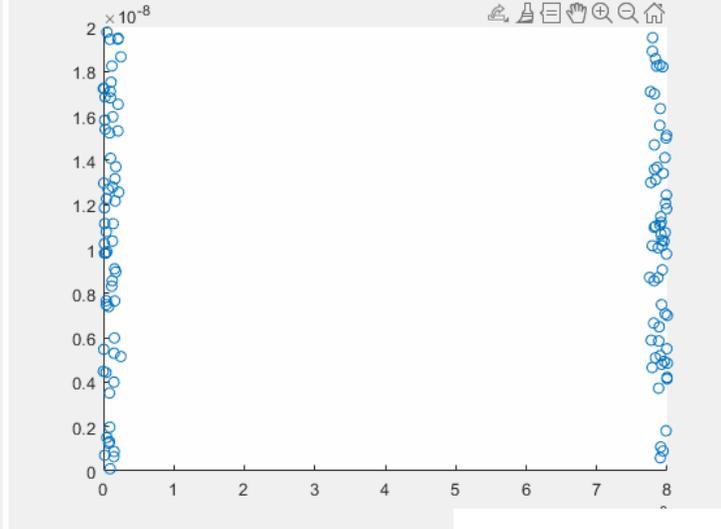
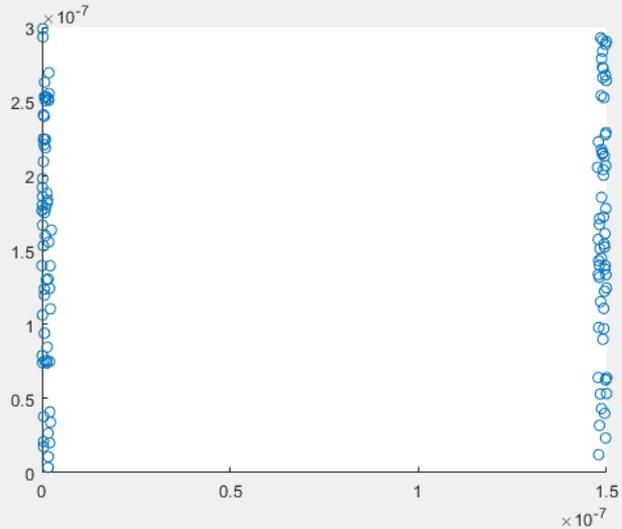
For $I_L = I_U = 0$ $T_{ij} = T_{ji}$ with $j \neq \{S, D\}$

Song A., Physical review B 59.15 (1999): 9806.

Truccolo et al. *Solid-State Electronics* 194 (2022): 108314.



Model: Monte Carlo/ Poisson scheme



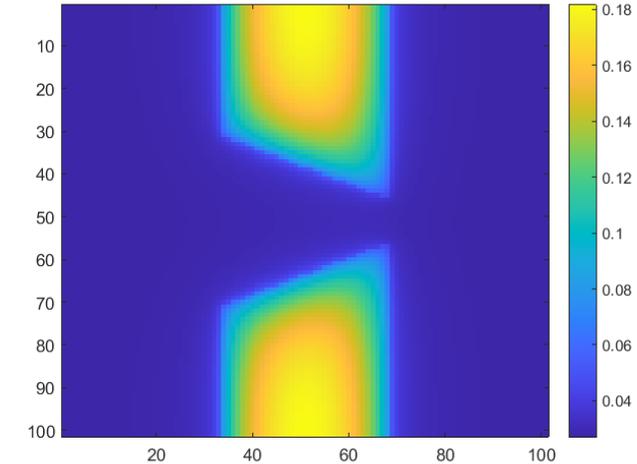
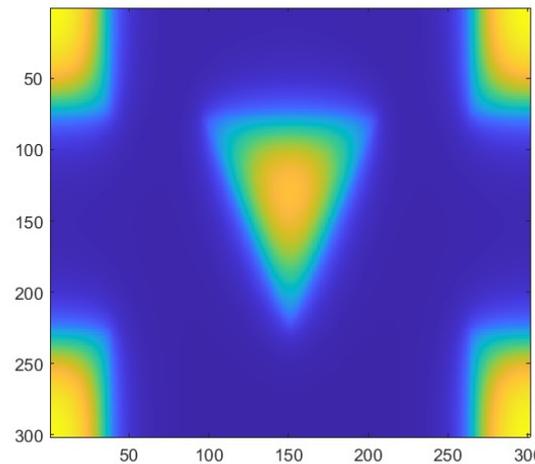
Charge motion according to semiclassical equation

$$\begin{cases} \varepsilon(\vec{k}) = \hbar v_f |\vec{k}| \\ \hbar \dot{\vec{k}} = -q \vec{E}(r) \\ \dot{\vec{r}} = \frac{1}{\hbar} \frac{\partial \varepsilon(\vec{k})}{\partial \vec{k}} = v_f \frac{\vec{k}(t)}{|\vec{k}(t)|} \end{cases}$$



Non-linear 3D Poisson equation

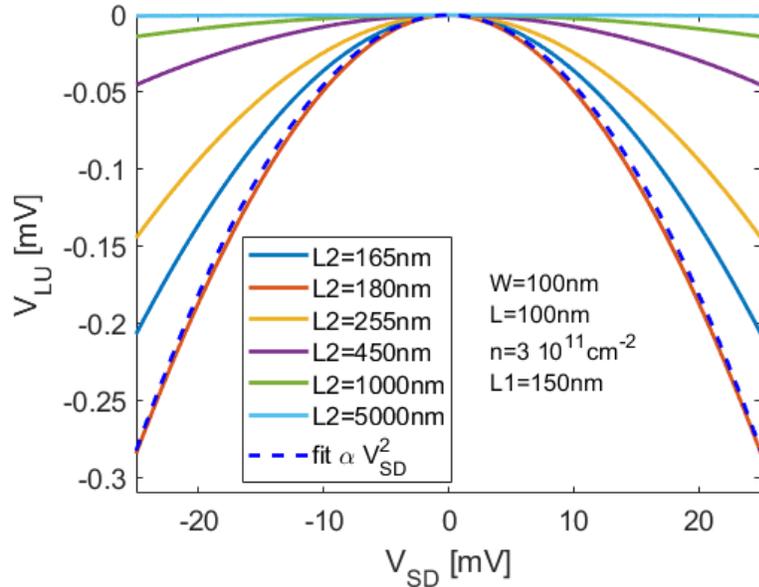
$$\nabla(\varepsilon \nabla \varphi^{(k+1)}) = \delta(z) n^{(k)} e^{\frac{q(\varphi^{(k+1)} - \varphi^{(k)})}{k_b T}}$$



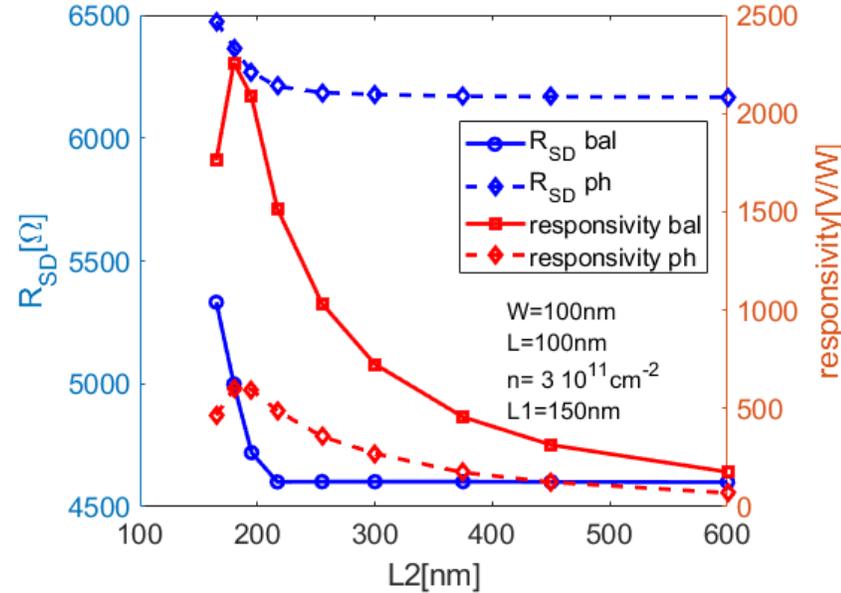
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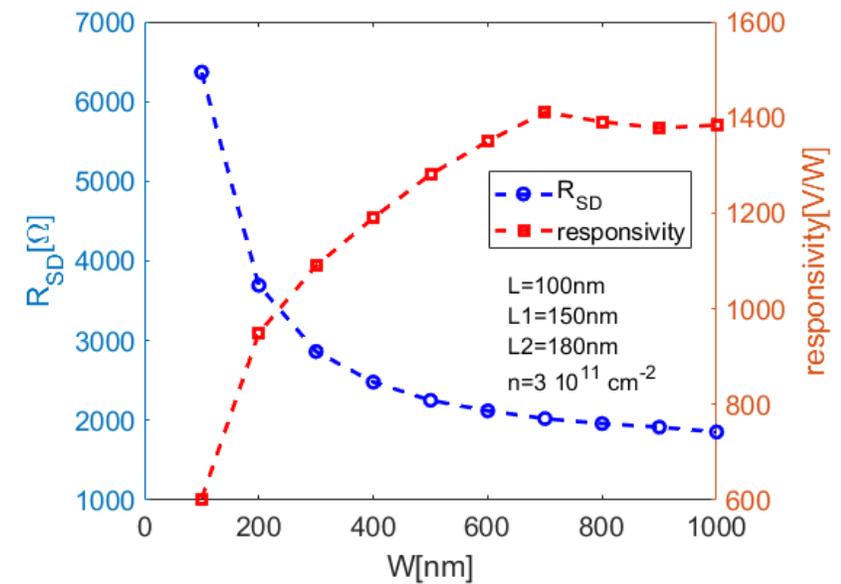
Results: 4-terminal device



(ballistic regime)



(ballistic & int.+remote phonons)

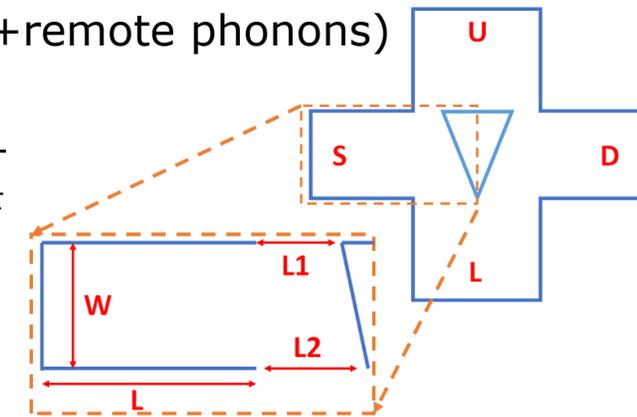


(int.+remote phonons)

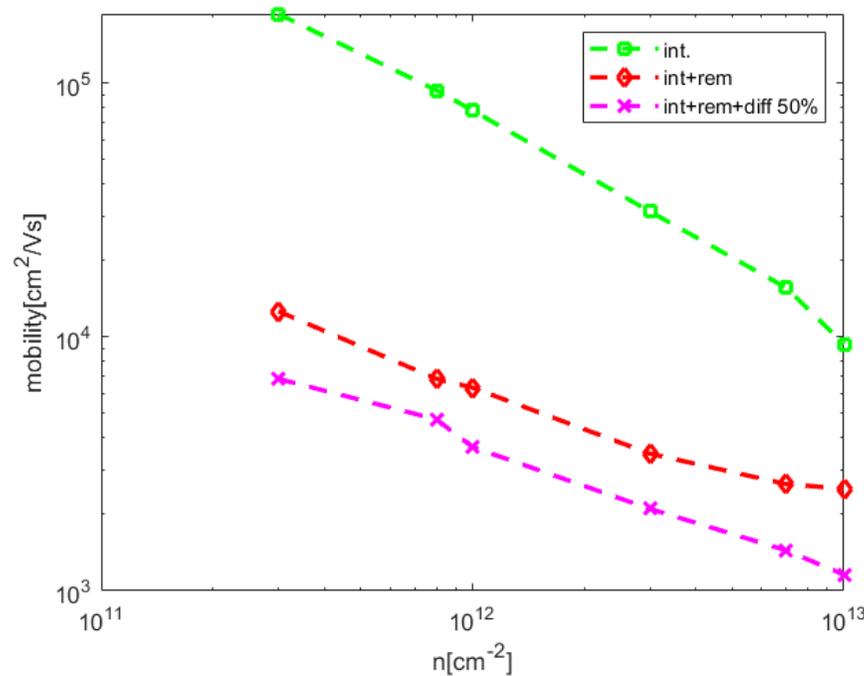
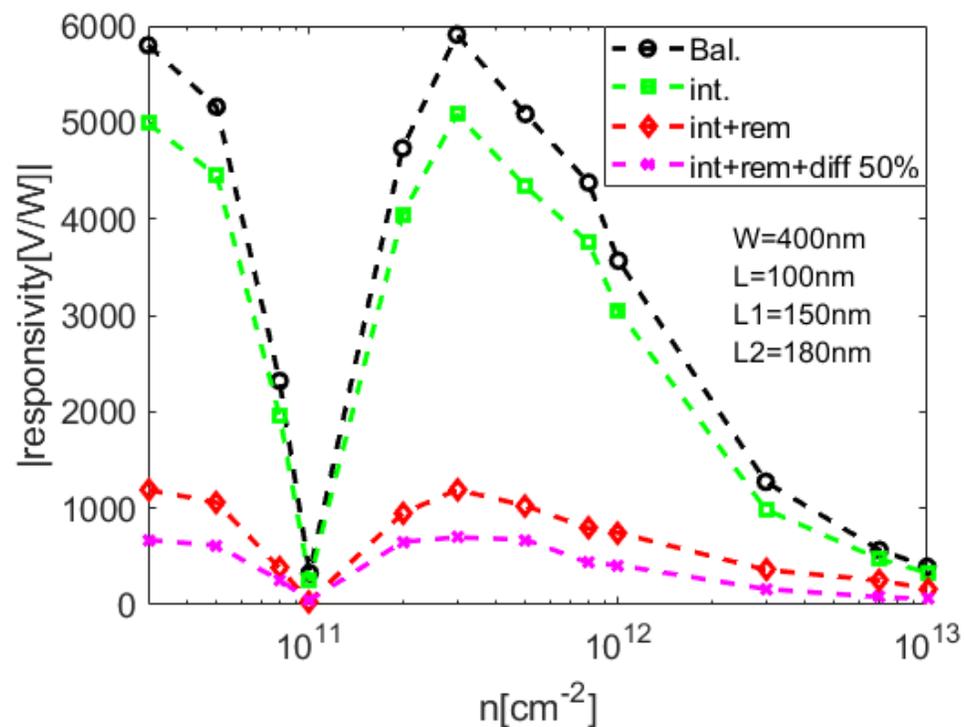
$$responsivity = \lim_{V_{DS} \rightarrow 0} \frac{V_{LU}}{P_{input}}$$

□ Device characterization as a function of geometrical parameters

Truccolo et al. *Solid-State Electronics* 194 (2022): 108314.

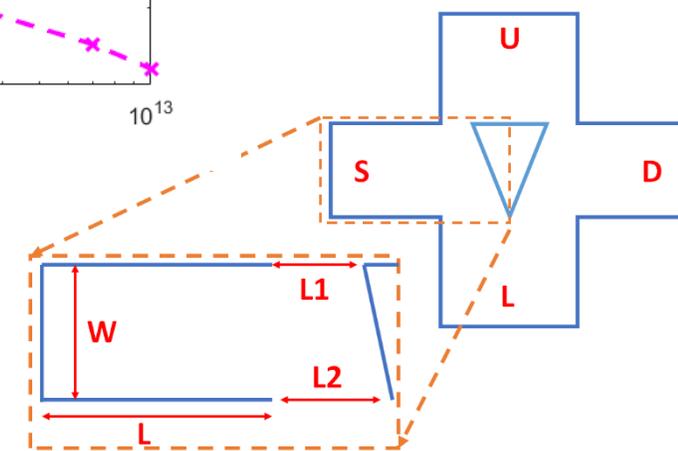


Results: 4-terminal device



- Device performance for different transport condition

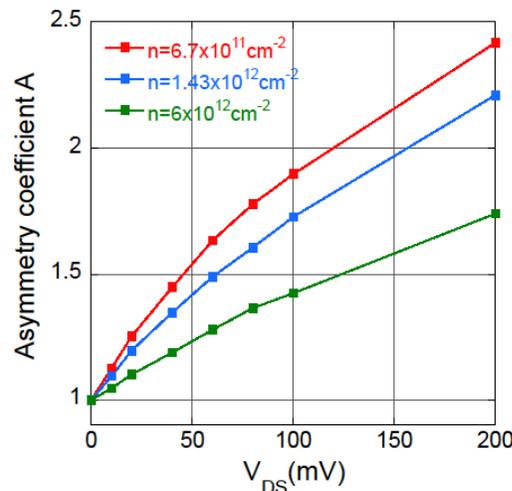
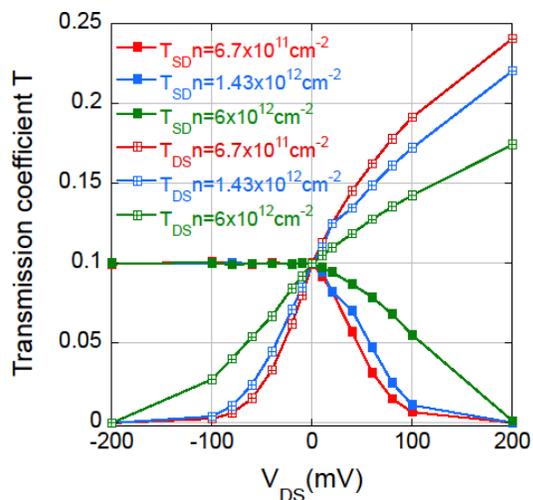
Truccolo et al. *Solid-State Electronics* 194 (2022): 108314.



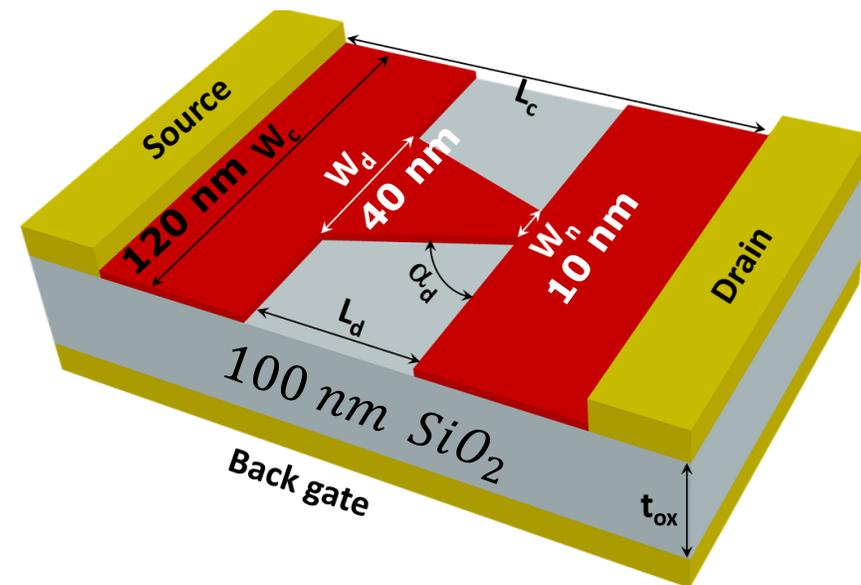
Results: 2-terminal device

Uniform electric field regime

$$A \approx \frac{T_{DS(+V_{DS})}}{T_{SD(-V_{DS})}}$$

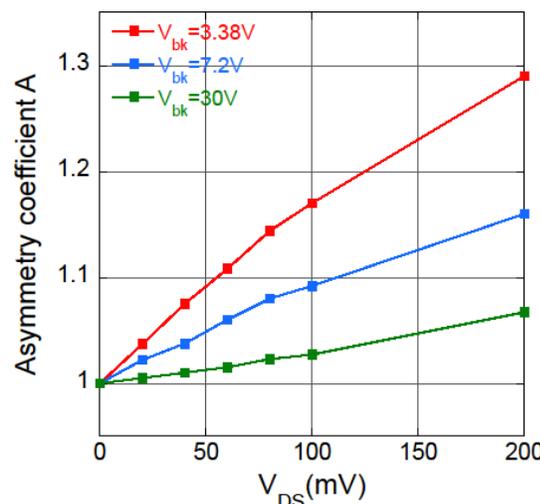
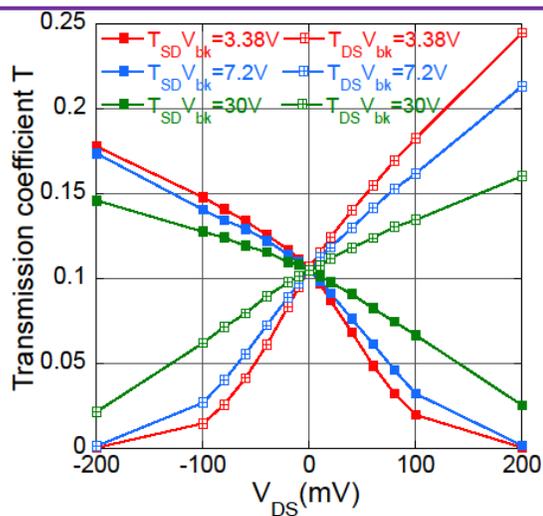


- Higher gate voltage induces higher electron density on Gr
- The Fermi wave vector on Gr is $k_f = \sqrt{2\pi n}$
- More electric field E_x needed to align the injected electrons into the device
- **Reduction of asymmetry**



Self-consistent regime

$$A = \frac{I_{DS(+V_{DS})}}{I_{SD(-V_{DS})}}$$



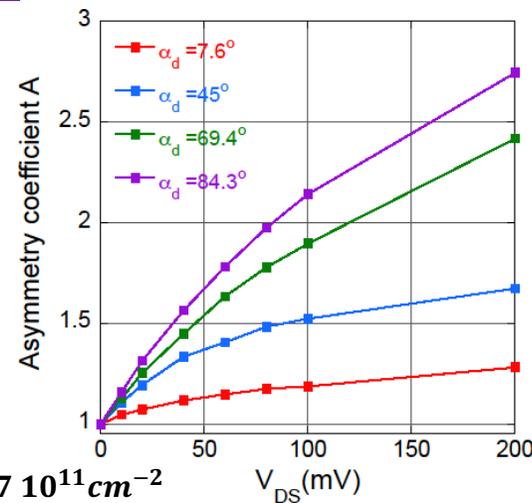
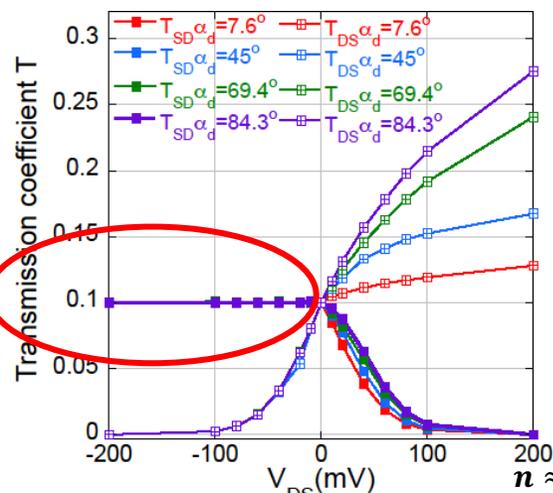
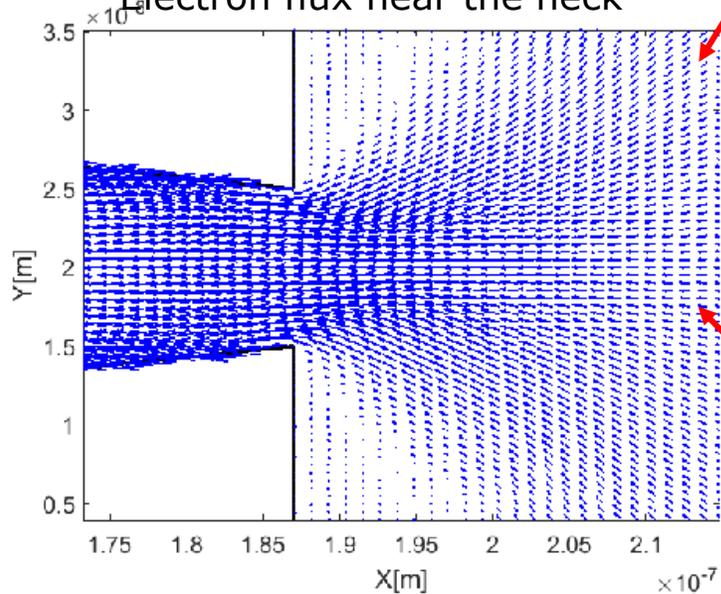
Truccolo et al., IEEE TED, vol. 71, no. 2, pp. 1294-1301

Results: 2-terminal device

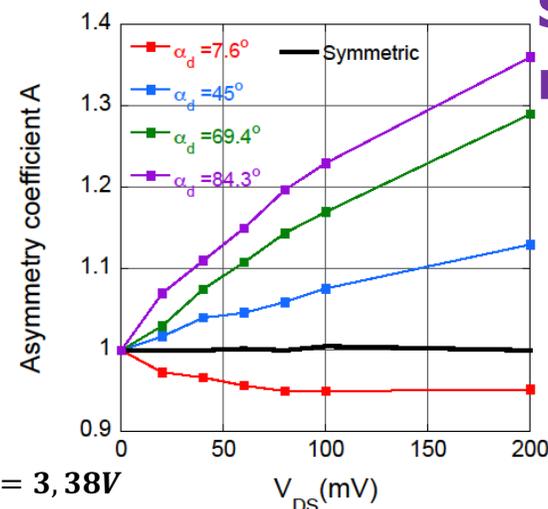
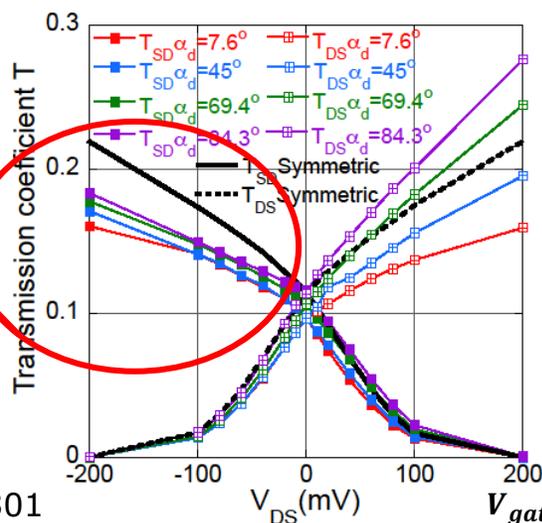
- The electrostatics effects in proximity of the neck cause an extra electrons injection from Drain to Source terminals

➤ **Reduction of asymmetry**

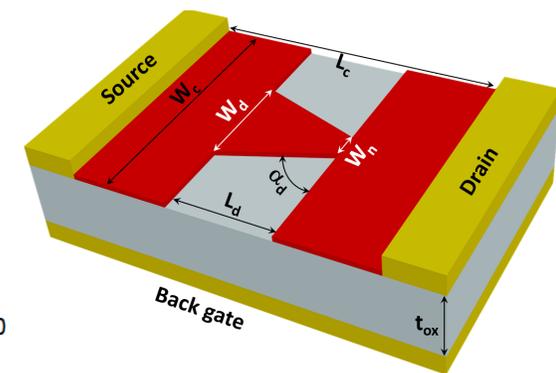
Electron flux near the neck



Uniform electric field regime



Self-consistent regime



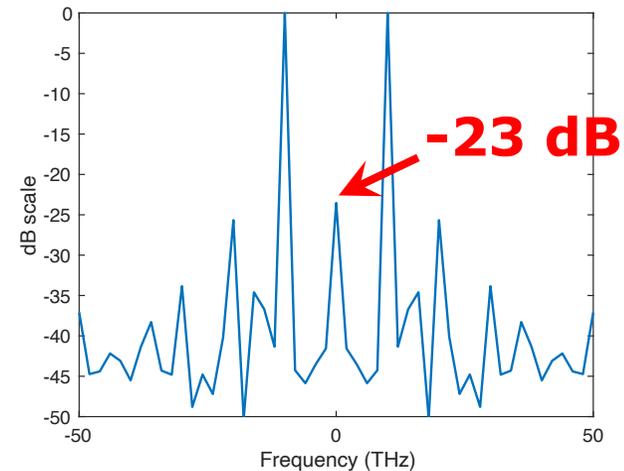
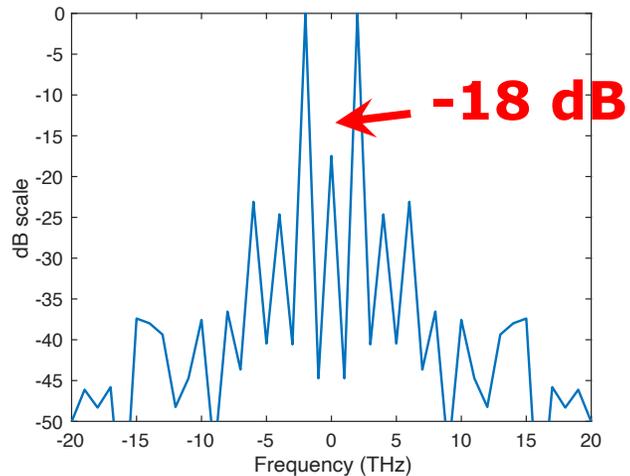
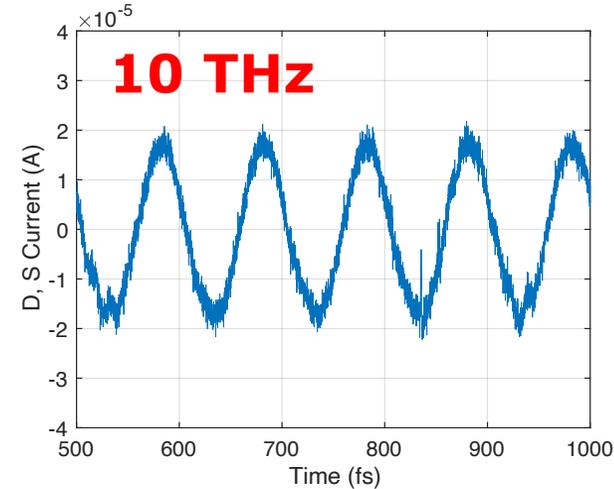
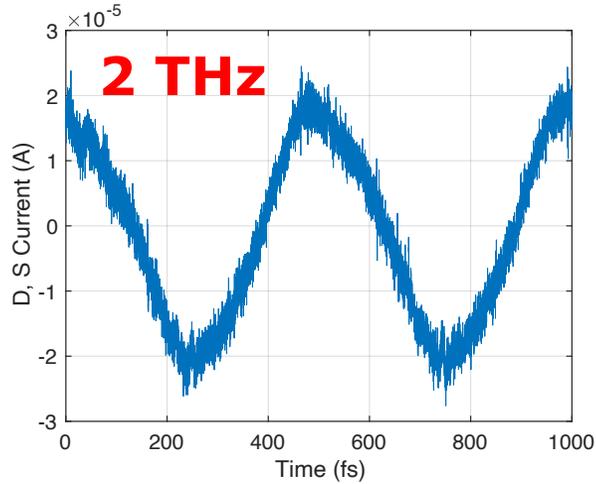
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Results: 2-terminal time domain

$$\nabla^2 \vec{A} - \frac{1}{c^2} \frac{\partial^2 \vec{A}}{\partial t^2} = -\mu \vec{J}_i$$

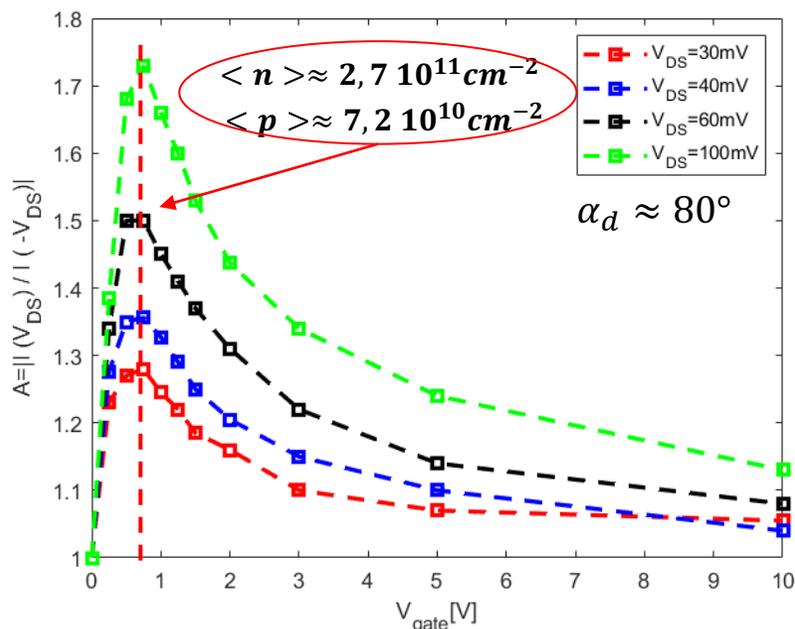
$$\nabla^2 \varphi - \frac{1}{c^2} \frac{\partial^2 \varphi}{\partial t^2} = -\rho / \epsilon$$

Poisson / Maxwell
eq.

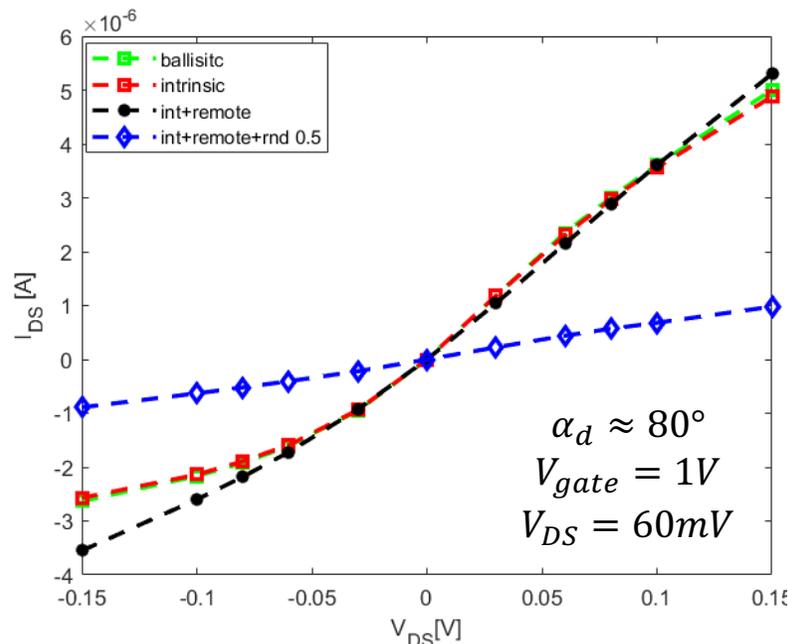


- **Device frequency limit?**
- **Limit of semi-classical time domain analysis**
- **Photon-electron interaction must be taken into account !**

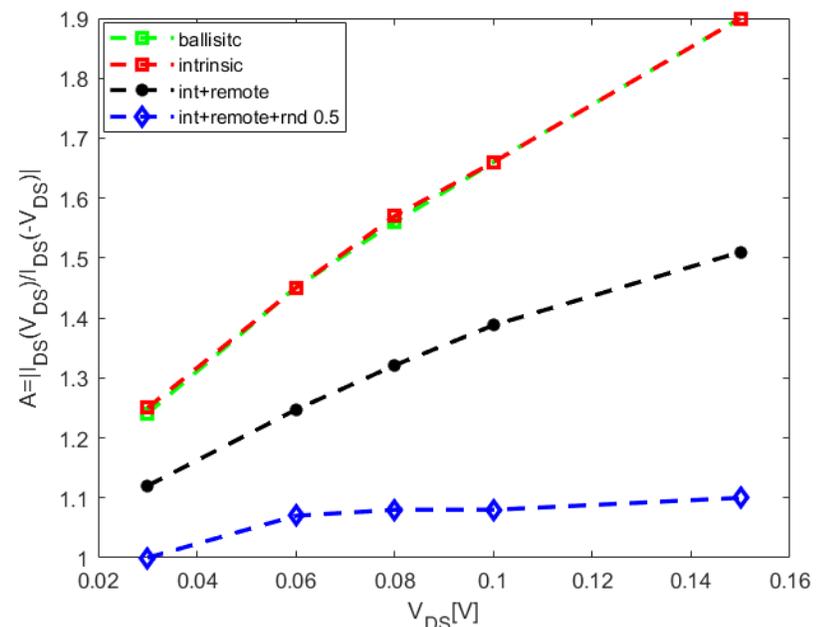
Results: Mixed transport & effects of scattering in 2-terminal device



(mixed transport in ballistic regime)

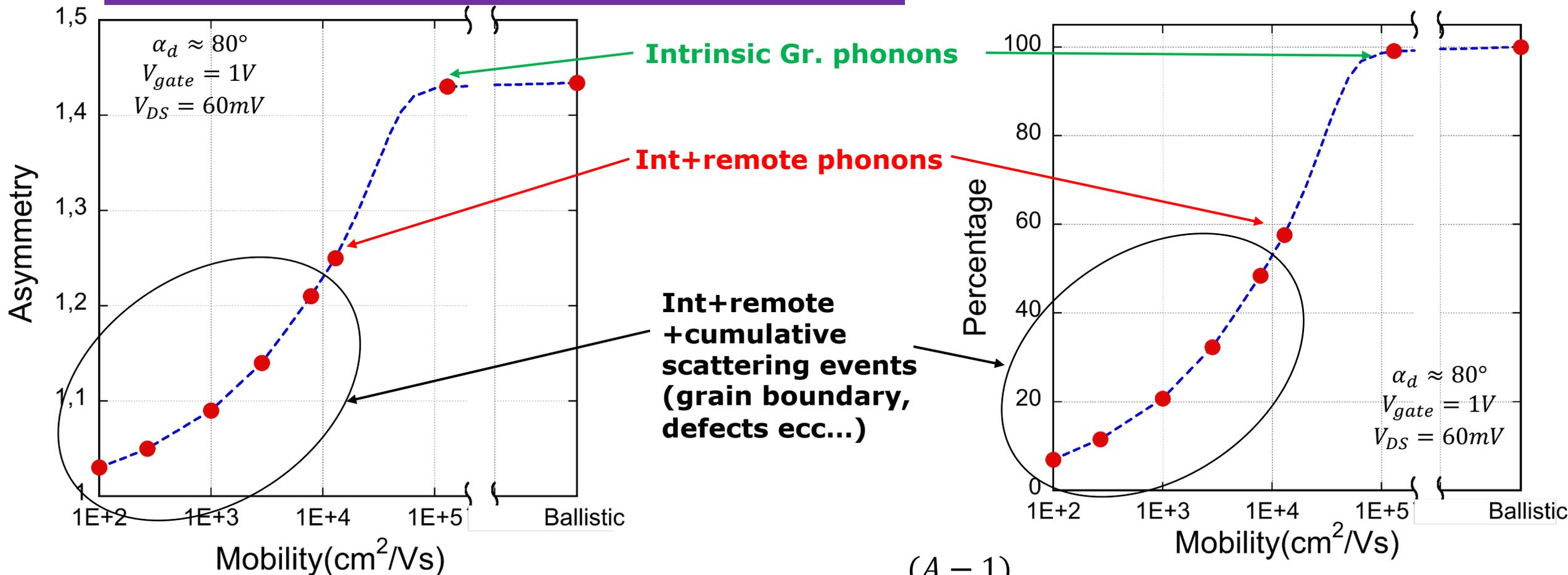


(mixed transport with int.+remote phonons + random scattering)



Truccolo et al. under publication

Results: Effects of scattering in 2-terminal device



$$Percentage = \frac{(A - 1)}{(A_{max} - 1)}$$

Truccolo et al. under publication

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Conclusion: Overview

➤ **progressive complexity of the simulations**

- I. MC uniform electric field simulations & Landauer-Buttiker formalism
- II. Self-consistent MC simulation (only ballistic)
- III. Self-consistent MC simulations with different scattering mechanisms

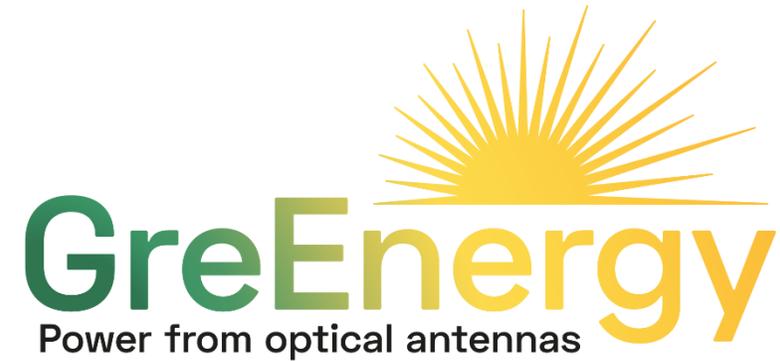
➤ **Time domain simulations**

- I. Limit of the semi-classical time domain analysis

➤ **Future goals**

- I. Self-consistent simulation for the 4-terminal device with different transport condition
- II. Inclusion of electron/photon interaction

Thank you!



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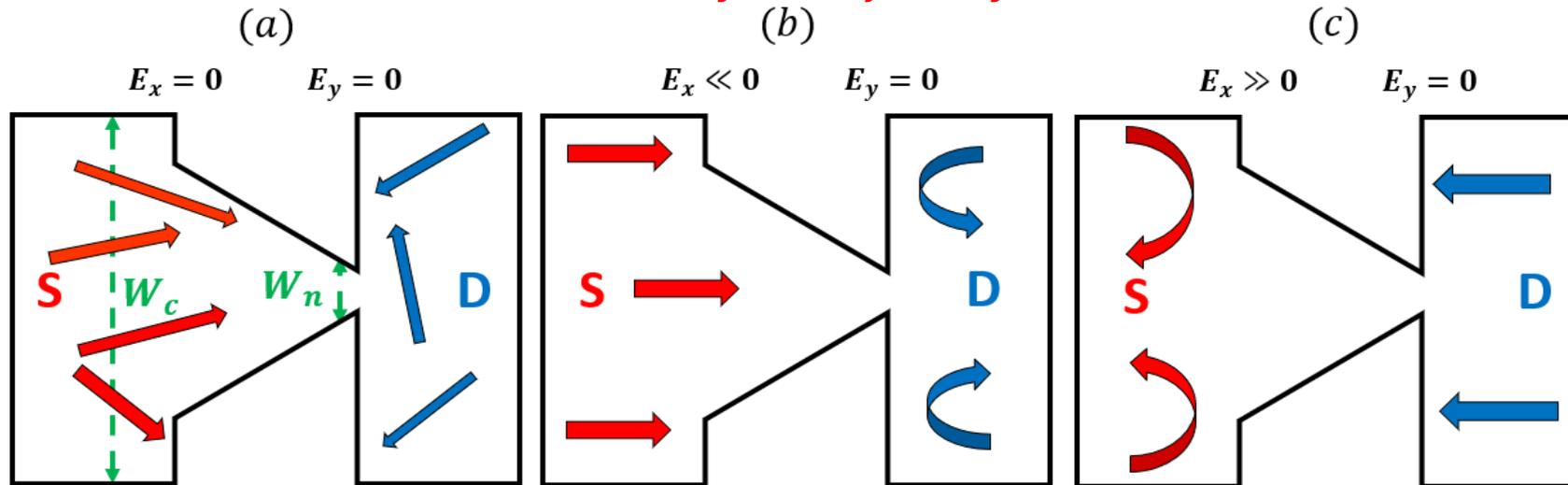
This project has received funding from the European Union's Horizon 2020 research and innovation programme under grant agreement No 101006963 (GreEnergy).

Backup slides

Uniform electric field regime: working principle

Uniform electric field: $E_x = -\frac{V_{DS}}{L_c}$ $E_y = 0$

$$T_{ij} = \frac{n \text{ electrons pass through } i}{\text{total electrons injected from } j}$$



$$T_{DS} = T_{SD} = \frac{W_n}{W_c}$$

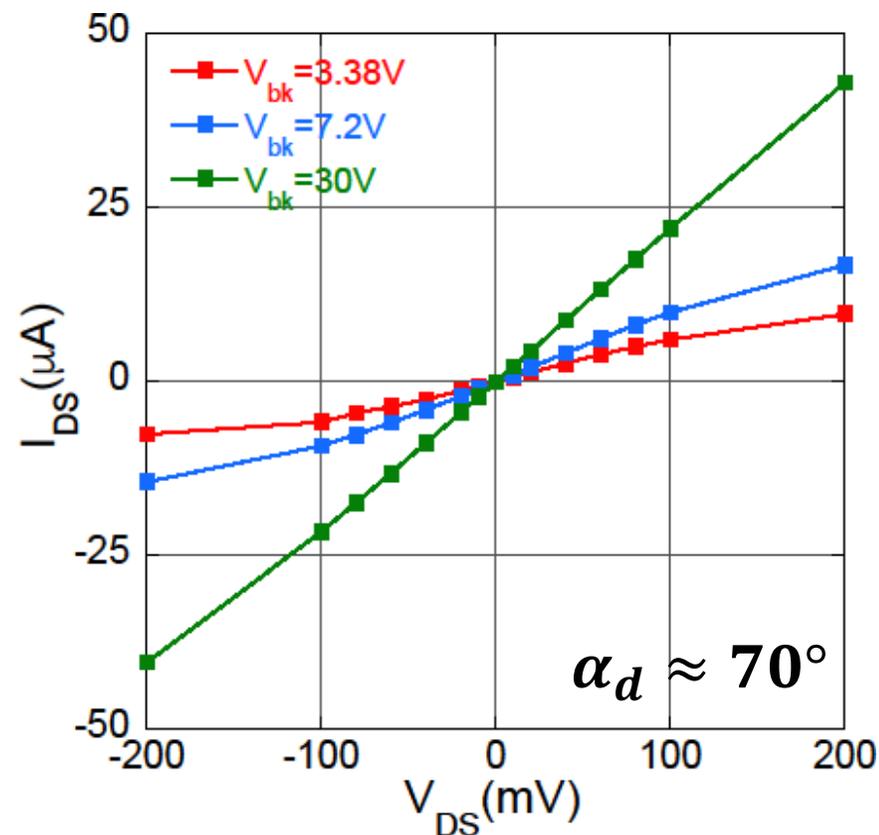
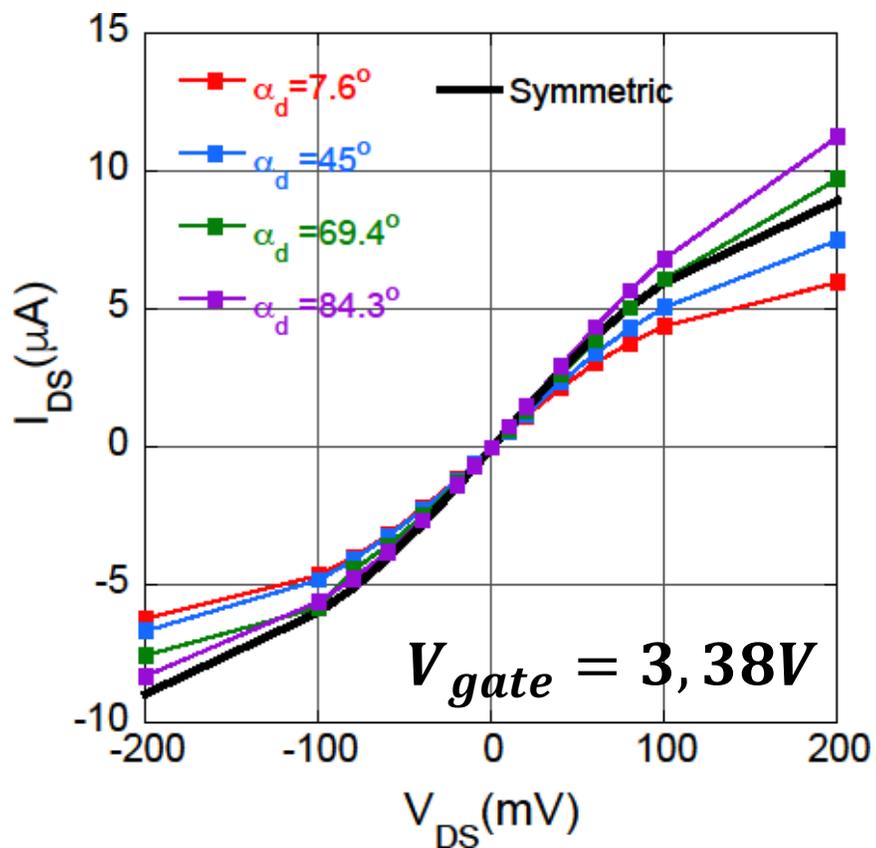
$$T_{DS} > \frac{W_n}{W_c}$$

$$T_{SD} \rightarrow 0$$

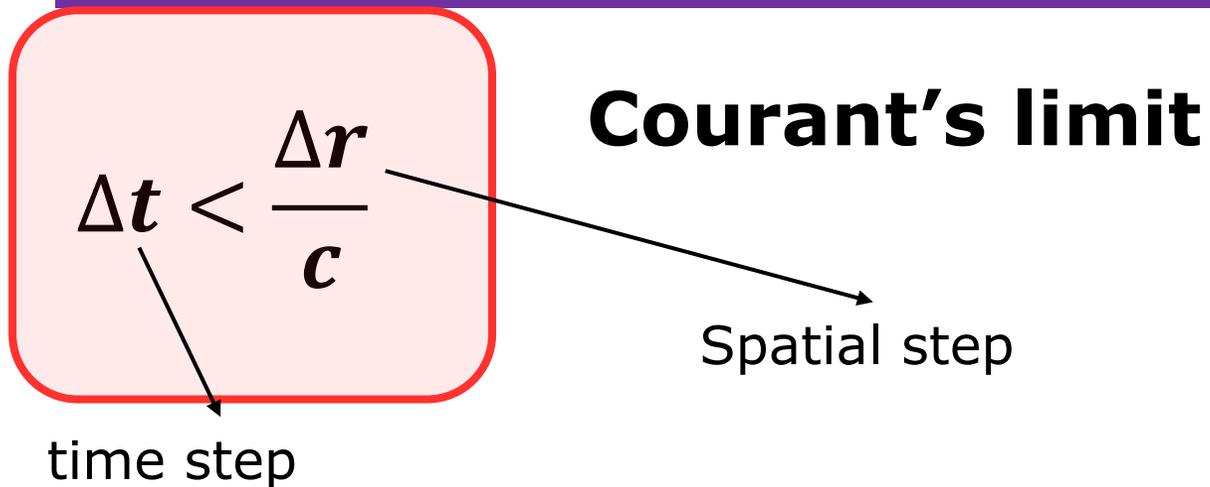
$$T_{DS} \rightarrow 0$$

$$T_{SD} = \frac{W_n}{W_c}$$

Self-consistent simulation: I-V 2-terminal



FDTD stability



$\Delta r \approx 1nm$ (mesh dimensions) \longrightarrow $\Delta t \approx 10^{-18}s$

@ 1 THz 1period = $10^{-12}s$ \longrightarrow 10^6 step

@ 1 GHz 1period = $10^{-9}s$ \longrightarrow 10^9 step

Every step each mesh pixel must be filled with particles (well defined density matrix)

high computation time